

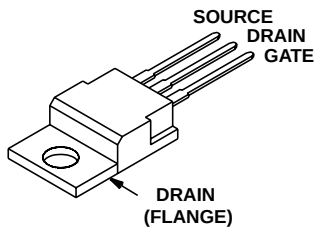
55A, 60V, 0.019 Ohm, N-Channel, Logic Level UltraFET Power MOSFET



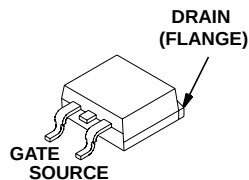
Packaging

JEDEC TO-220AB

JEDEC TO-263AB

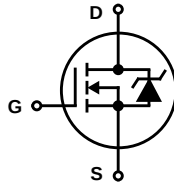


HUF76432P3



HUF76432S3S

Symbol



Features

- Ultra Low On-Resistance
 - $r_{DS(ON)} = 0.017\Omega$, $V_{GS} = 10V$
 - $r_{DS(ON)} = 0.019\Omega$, $V_{GS} = 5V$
- Simulation Models
 - Temperature Compensated PSPICE® and SABER™ Electrical Models
 - Spice and SABER Thermal Impedance Models
 - www.Intersil.com
- Peak Current vs Pulse Width Curve
- UIS Rating Curve
- Switching Time vs R_{GS} Curves

Ordering Information

PART NUMBER	PACKAGE	BRAND
HUF76432P3	TO-220AB	76432P
HUF76432S3S	TO-263AB	76432S

NOTE: When ordering, use the entire part number. Add the suffix T to obtain the variant in tape and reel, e.g., HUF76432S3ST.

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

	HUF76432P3, HUF76432S3S	UNITS
Drain to Source Voltage (Note 1)	60	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1)	60	V
Gate to Source Voltage	± 16	V
Drain Current		
Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 5V$)	55	A
Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 10V$) (Figure 2)	59	A
Continuous ($T_C = 100^\circ\text{C}$, $V_{GS} = 5V$)	39	A
Continuous ($T_C = 100^\circ\text{C}$, $V_{GS} = 4.5V$) (Figure 2)	37	A
Pulsed Drain Current	Figure 4	
Pulsed Avalanche Rating	Figures 6, 17, 18	
Power Dissipation	130	W
Derate Above 25°C	0.87	mW/ $^\circ\text{C}$
Operating and Storage Temperature	-55 to 175	$^\circ\text{C}$
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s.	300	$^\circ\text{C}$
Package Body for 10s, See Techbrief TB334.	260	$^\circ\text{C}$

NOTES:

1. $T_J = 25^\circ\text{C}$ to 150°C .

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

HUF76432P3, HUF76432S3S

Electrical Specifications $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
OFF STATE SPECIFICATIONS							
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V (Figure 12)	60	-	-	V	
		I _D = 250μA, V _{GS} = 0V , T _C = -40°C (Figure 12)	55	-	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 55V, V _{GS} = 0V	-	-	1	μA	
		V _{DS} = 50V, V _{GS} = 0V, T _C = 150°C	-	-	250	μA	
Gate to Source Leakage Current	I _{GSS}	V _{GS} = ±16V	-	-	±100	nA	
ON STATE SPECIFICATIONS							
Gate to Source Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D = 250μA (Figure 11)	1	-	3	V	
Drain to Source On Resistance	r _{DS(ON)}	I _D = 59A, V _{GS} = 10V (Figures 9, 10)	-	0.014	0.017	Ω	
		I _D = 39A, V _{GS} = 5V (Figure 9)	-	0.016	0.019	Ω	
		I _D = 37A, V _{GS} = 4.5V (Figure 9)	-	0.017	0.021	Ω	
THERMAL SPECIFICATIONS							
Thermal Resistance Junction to Case	R _{θJC}	TO-220AB and TO-263AB	-	-	1.15	°C/W	
Thermal Resistance Junction to Ambient	R _{θJA}		-	-	62	°C/W	
SWITCHING SPECIFICATIONS (V _{GS} = 4.5V)							
Turn-On Time	t _{ON}	V _{DD} = 30V, I _D = 37A V _{GS} = 4.5V, R _{GS} = 6.2Ω (Figures 15, 21, 22)	-	-	400	ns	
Turn-On Delay Time	t _{d(ON)}		-	14	-	ns	
Rise Time	t _r		-	250	-	ns	
Turn-Off Delay Time	t _{d(OFF)}		-	26	-	ns	
Fall Time	t _f		-	82	-	ns	
Turn-Off Time	t _{OFF}		-	-	160	ns	
SWITCHING SPECIFICATIONS (V _{GS} = 10V)							
Turn-On Time	t _{ON}	V _{DD} = 30V, I _D = 60A V _{GS} = 10V, R _{GS} = 6.8Ω (Figures 16, 21, 22)	-	-	165	ns	
Turn-On Delay Time	t _{d(ON)}		-	9.0	-	ns	
Rise Time	t _r		-	100	-	ns	
Turn-Off Delay Time	t _{d(OFF)}		-	53	-	ns	
Fall Time	t _f		-	107	-	ns	
Turn-Off Time	t _{OFF}		-	-	240	ns	
GATE CHARGE SPECIFICATIONS							
Total Gate Charge	Q _{g(TOT)}	V _{GS} = 0V to 10V	V _{DD} = 30V, I _D = 39A, I _{g(REF)} = 1.0mA (Figures 14, 19, 20)	-	44	53	nC
Gate Charge at 5V	Q _{g(5)}	V _{GS} = 0V to 5V		-	24	29	nC
Threshold Gate Charge	Q _{g(TH)}	V _{GS} = 0V to 1V		-	1.6	2	nC
Gate to Source Gate Charge	Q _{gs}			-	4.3	-	nC
Reverse Transfer Capacitance	Q _{gd}			-	9.8	-	nC
CAPACITANCE SPECIFICATIONS							
Input Capacitance	C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz (Figure 13)	-	1765	-	pF	
Output Capacitance	C _{OSS}		-	470	-	pF	
Reverse Transfer Capacitance	C _{RSS}		-	75	-	pF	

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V_{SD}	$I_{SD} = 39\text{A}$	-	-	1.25	V
		$I_{SD} = 20\text{A}$	-	-	1.00	V
Reverse Recovery Time	t_{rr}	$I_{SD} = 39\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	65	ns
Reverse Recovered Charge	Q_{RR}	$I_{SD} = 39\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	-	120	nC

Typical Performance Curves

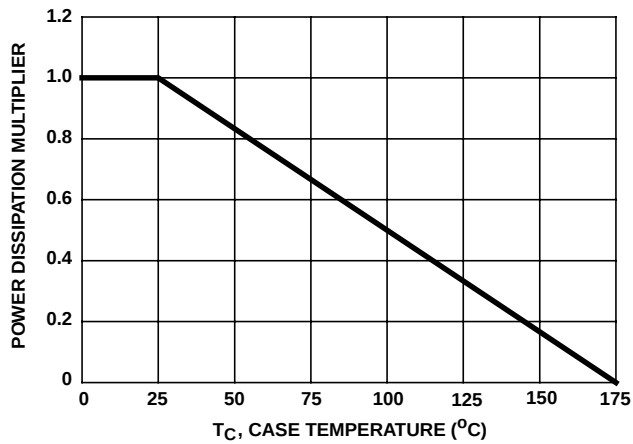


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

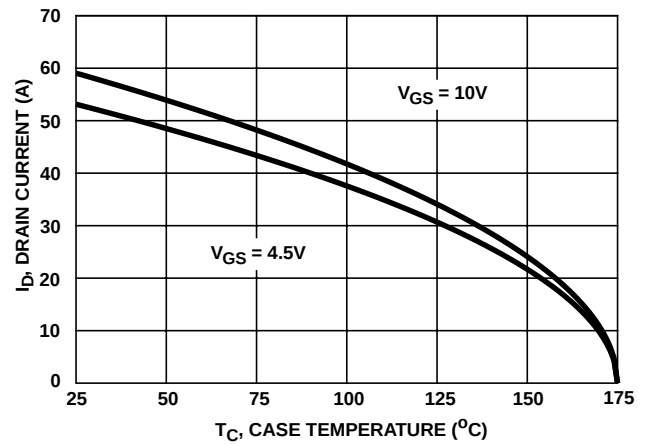


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

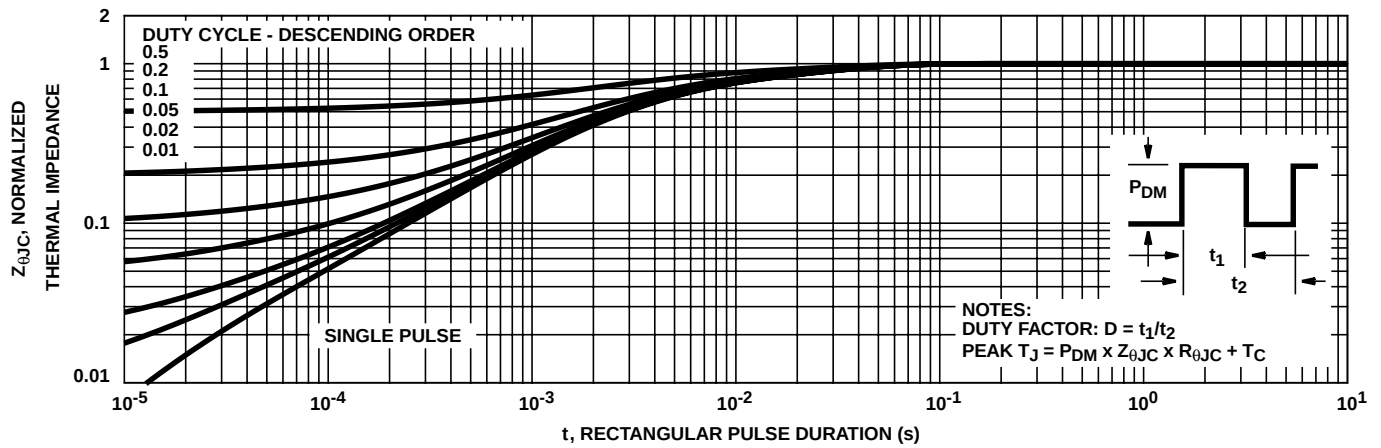


FIGURE 3. NORMALIZED MAXIMUM TRANSIENT THERMAL IMPEDANCE

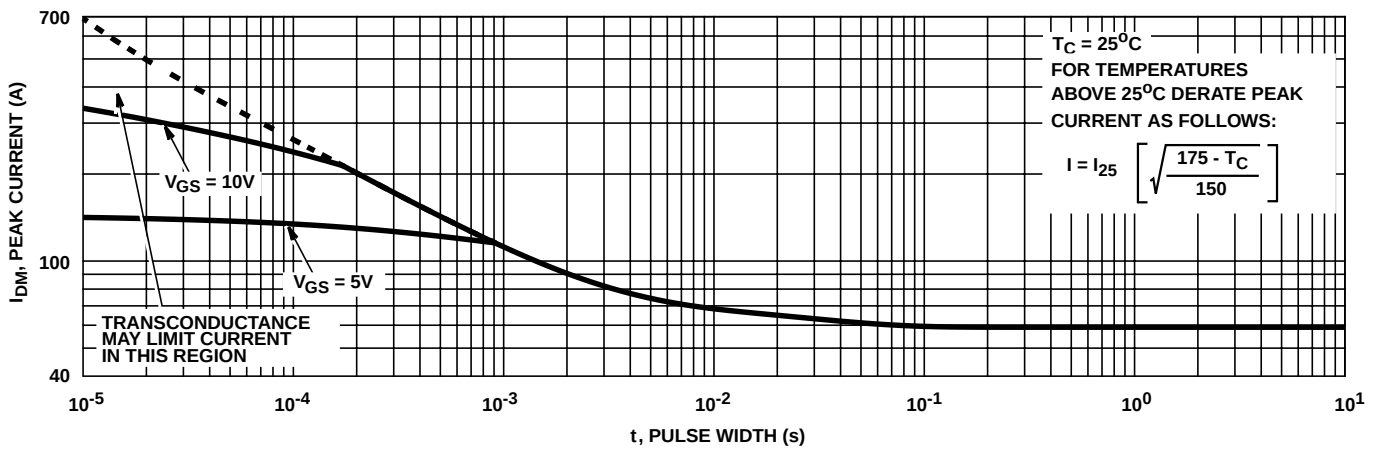
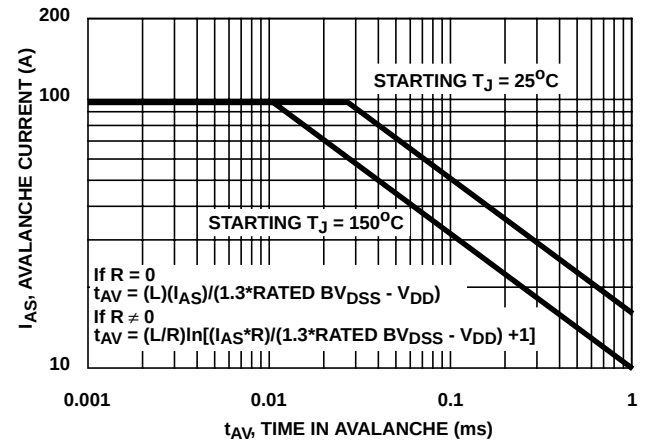
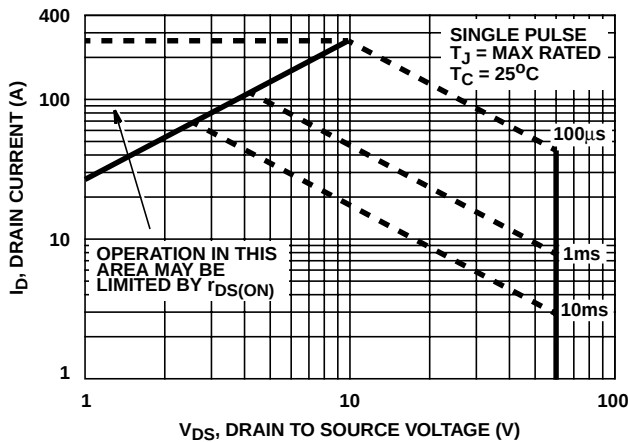
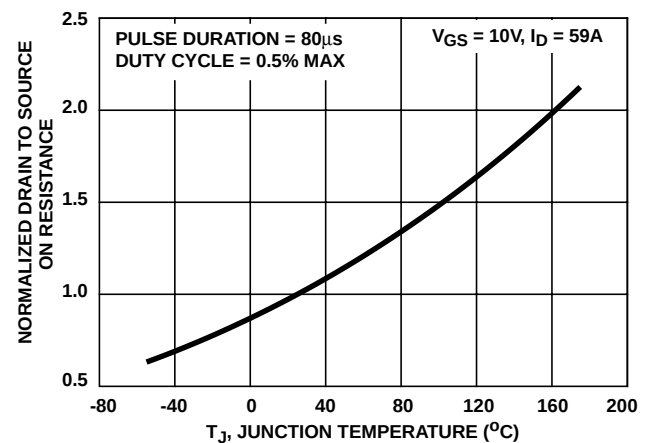
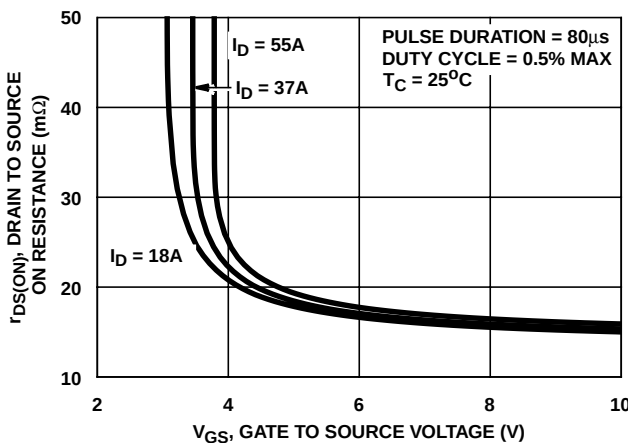
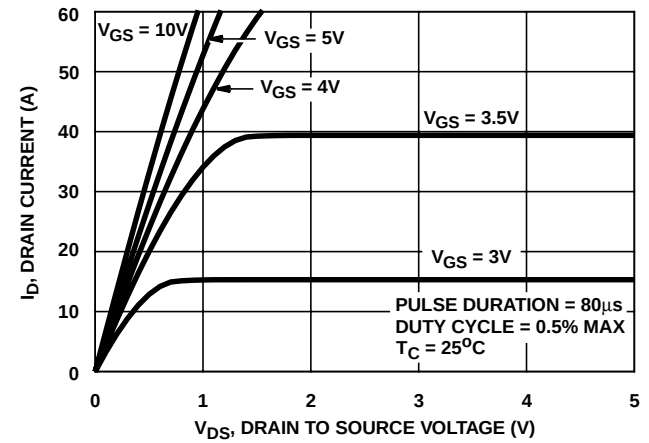
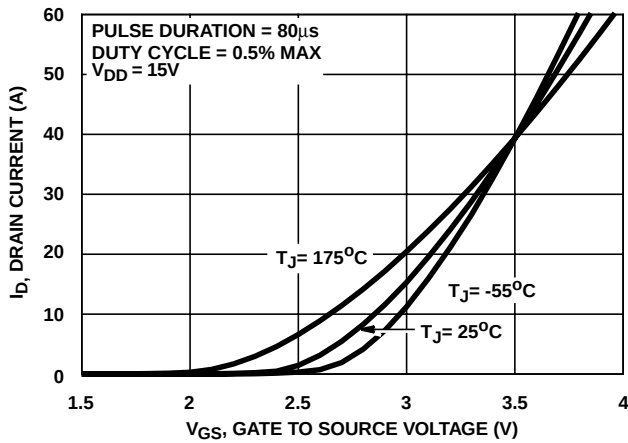


FIGURE 4. PEAK CURRENT CAPABILITY

Typical Performance Curves (Continued)



NOTE: Refer to Intersil Application Notes AN9321 and AN9322.



Typical Performance Curves (Continued)

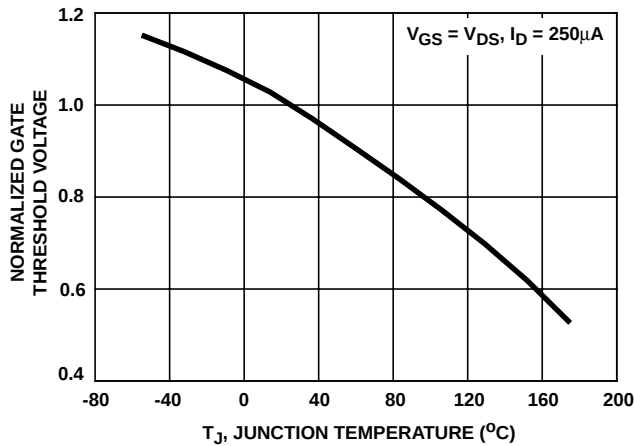


FIGURE 11. NORMALIZED GATE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE

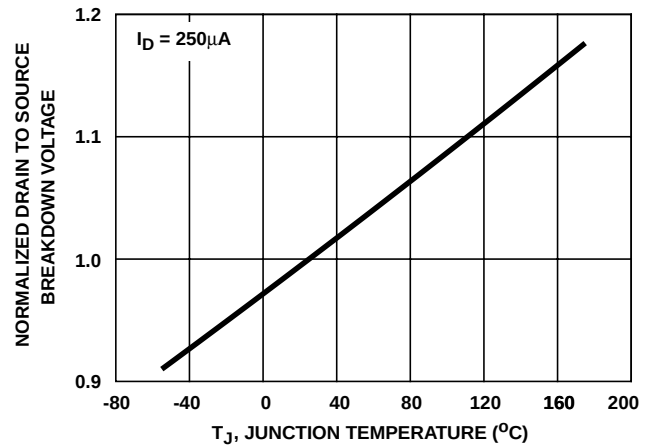


FIGURE 12. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

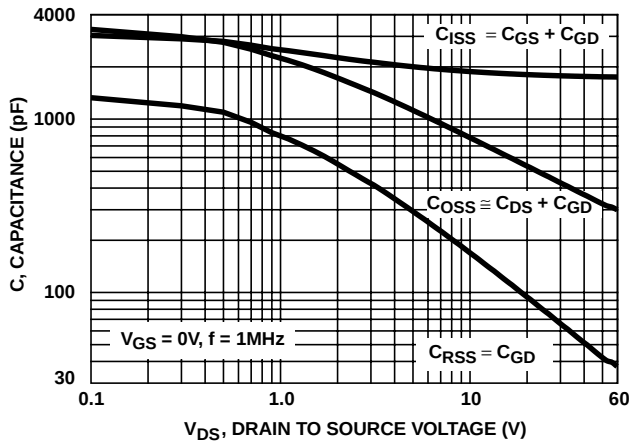
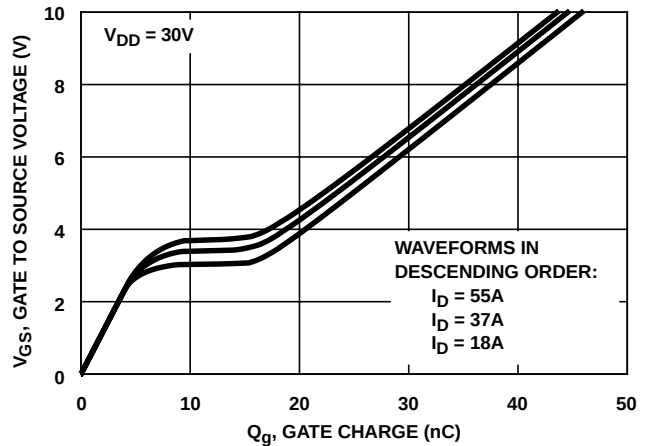


FIGURE 13. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



NOTE: Refer to Intersil Application Notes AN7254 and AN7260.

FIGURE 14. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT

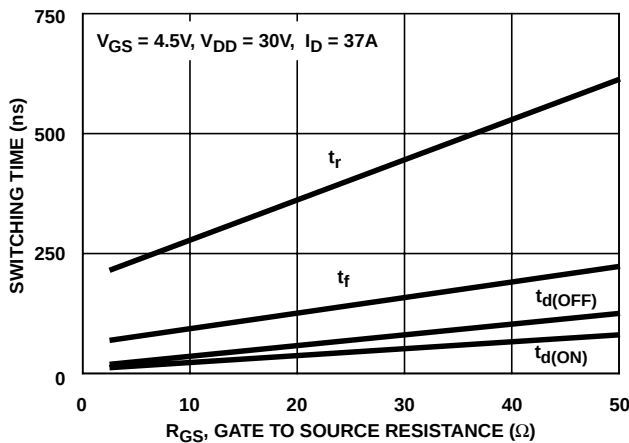


FIGURE 15. SWITCHING TIME vs GATE RESISTANCE

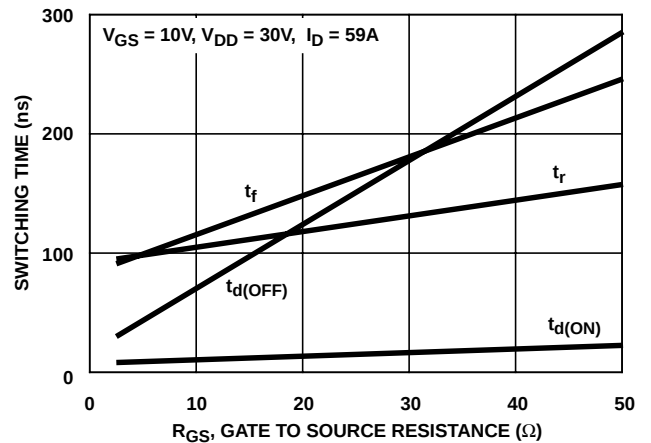


FIGURE 16. SWITCHING TIME vs GATE RESISTANCE

Test Circuits and Waveforms

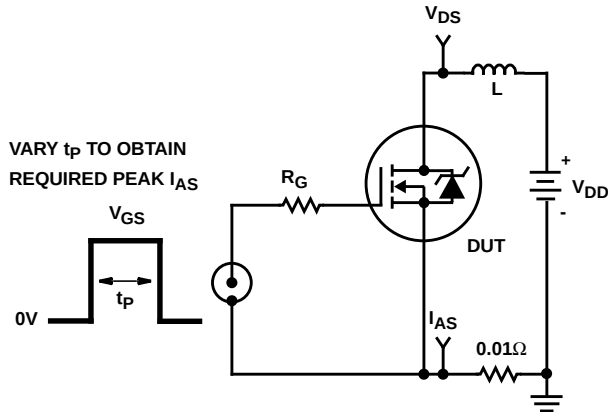


FIGURE 17. UNCLAMPED ENERGY TEST CIRCUIT

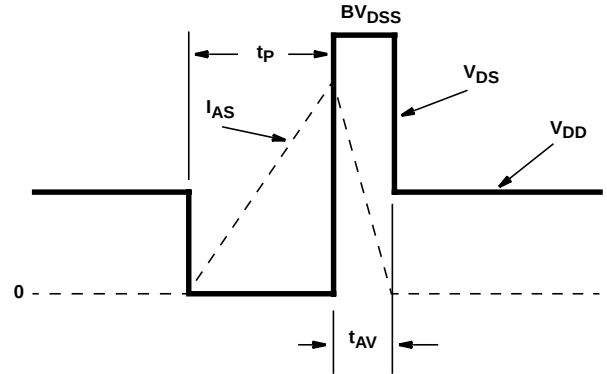


FIGURE 18. UNCLAMPED ENERGY WAVEFORMS

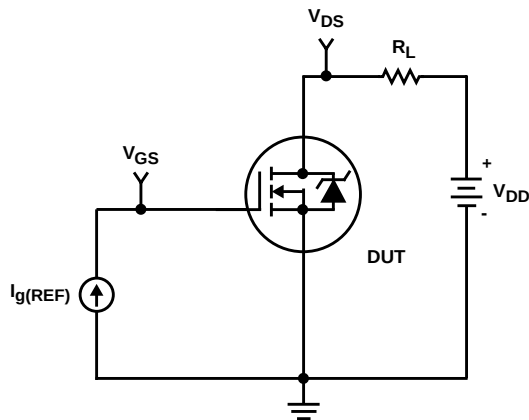


FIGURE 19. GATE CHARGE TEST CIRCUIT

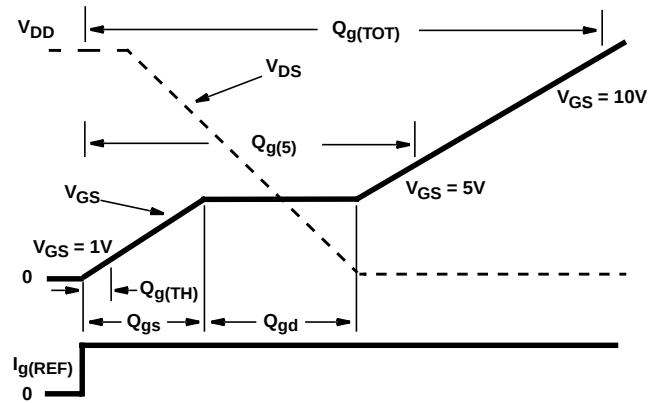


FIGURE 20. GATE CHARGE WAVEFORMS

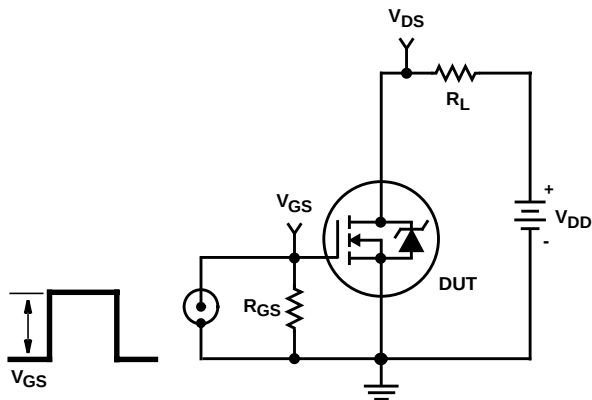


FIGURE 21. SWITCHING TIME TEST CIRCUIT

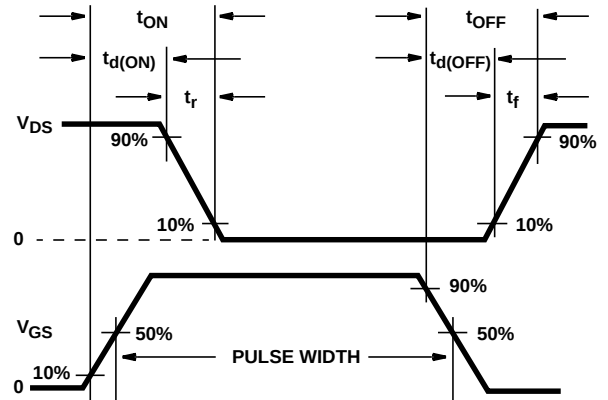


FIGURE 22. SWITCHING TIME WAVEFORM

PSPICE Electrical Model

..SUBCKT HUF76432 2 1 3 ; rev 14 July 1999

CA 12 8 2.45e-9
CB 15 14 2.45e-9
CIN 6 8 1.71e-9

DBODY 7 5 DBODYMOD
DBREAK 5 11 DBREAKMOD
DPLCAP 10 5 DPLCAPMOD

EBREAK 11 7 17 18 66.61
EDS 14 8 5 8 1
EGS 13 8 6 8 1
ESG 6 10 6 8 1
EVTHRES 6 21 19 8 1
EVTEMP 20 6 18 22 1

IT 8 17 1

LDRAIN 2 5 1e-9
LGATE 1 9 5.42e-9
LSOURCE 3 7 4.16e-9

MMED 16 6 8 8 MMEDMOD
MSTRO 16 6 8 8 MSTROMOD
MWEAK 16 21 8 8 MWEAKMOD

RBREAK 17 18 RBREAKMOD 1
RDRAIN 50 16 RDRAINMOD 7e-3
RGATE 9 20 2.29
RLDRAIN 2 5 10
RLGATE 1 9 54.2
RLSOURCE 3 7 41.6
RSLC1 5 51 RSLCMOD 1e-6
RSLC2 5 50 1e3
RSOURCE 8 7 RSOURCEMOD 6.5e-3
RVTHRES 22 8 RVTHRESMOD 1
RVTEMP 18 19 RVTEMPMOD 1

S1A 6 12 13 8 S1AMOD
S1B 13 12 13 8 S1BMOD
S2A 6 15 14 13 S2AMOD
S2B 13 15 14 13 S2BMOD

VBAT 22 19 DC 1

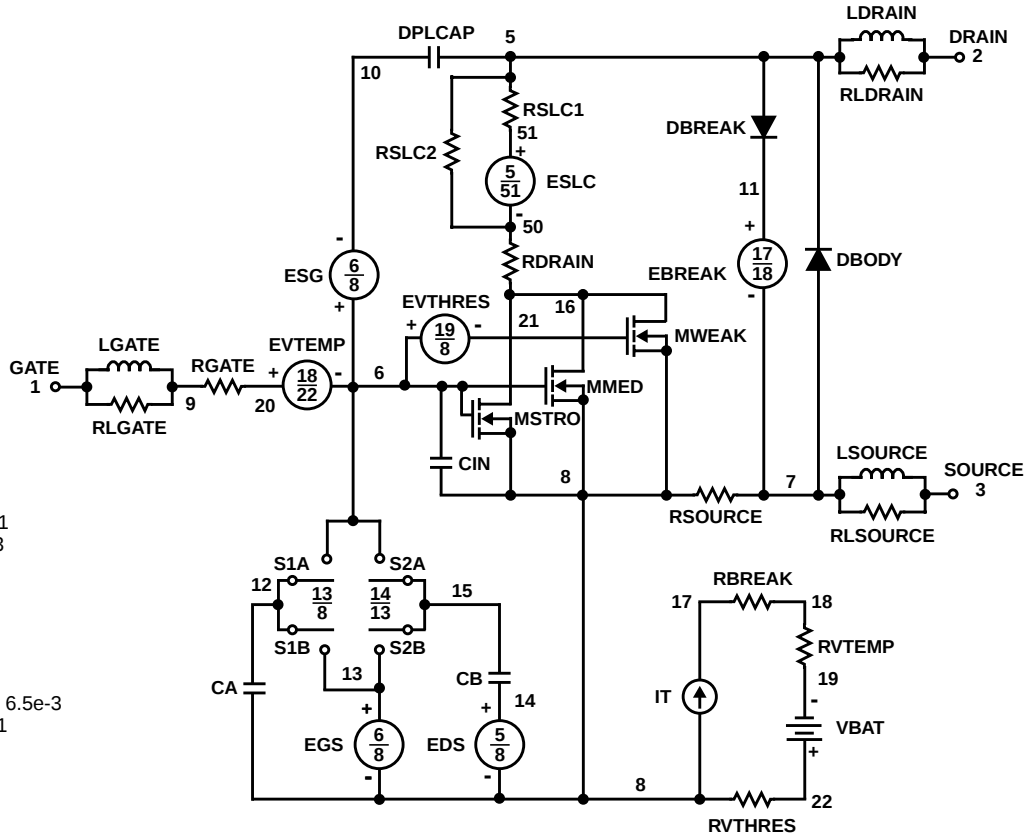
ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e-6*150),3))}

.MODEL DBODYMOD D (IS = 1.1e-12 IKF = 20 RS = 3.95e-3 TRS1 = 1.25e-3 TRS2 = 8.85e-6 CJO = 2.05e-9 TT = 2.67e-8 M = 0.5 XTI = 4.6)
.MODEL DBREAKMOD D (RS = 2.80e-1 TRS1 = 8.10e-4 TRS2 = -9.70e-6)
.MODEL DPLCAPMOD D (CJO = 1.5e-9 IS = 1e-30 N = 10 M = 0.9)
.MODEL MMEDMOD NMOS (VTO = 1.96 KP = 3.9 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 2.29)
.MODEL MSTROMOD NMOS (VTO = 2.35 KP = 90 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
.MODEL MWEAKMOD NMOS (VTO = 1.72 KP = 0.08 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u RG = 22.9 RS = 0.1)
.MODEL RBREAKMOD RES (TC1 = 1.18e-3 TC2 = 2.35e-7)
.MODEL RDRAINMOD RES (TC1 = 8.75e-3 TC2 = 1.85e-5)
.MODEL RSLCMOD RES (TC1 = 4.97e-3 TC2 = 5.25e-6)
.MODEL RSOURCEMOD RES (TC1 = 1.5e-3 TC2 = 1e-6)
.MODEL RVTHRESMOD RES (TC1 = -1.85e-3 TC2 = -9.48e-6)
.MODEL RVTEMPMOD RES (TC1 = -1.72e-3 TC2 = 9.50e-7)

.MODEL S1AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -6.2 VOFF = -2.4)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -2.4 VOFF = -6.2)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -1.1 VOFF = 0.5)
.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 0.5 VOFF = -1.1)

.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.



SPICE Thermal Model

REV 14 September 1999

HUF76432

CTHERM1 th 6 2.40e-3
 CTHERM2 6 5 8.40e-3
 CTHERM3 5 4 9.30e-3
 CTHERM4 4 3 9.60e-3
 CTHERM5 3 2 1.28e-3
 CTHERM6 2 TL 1.07e-1

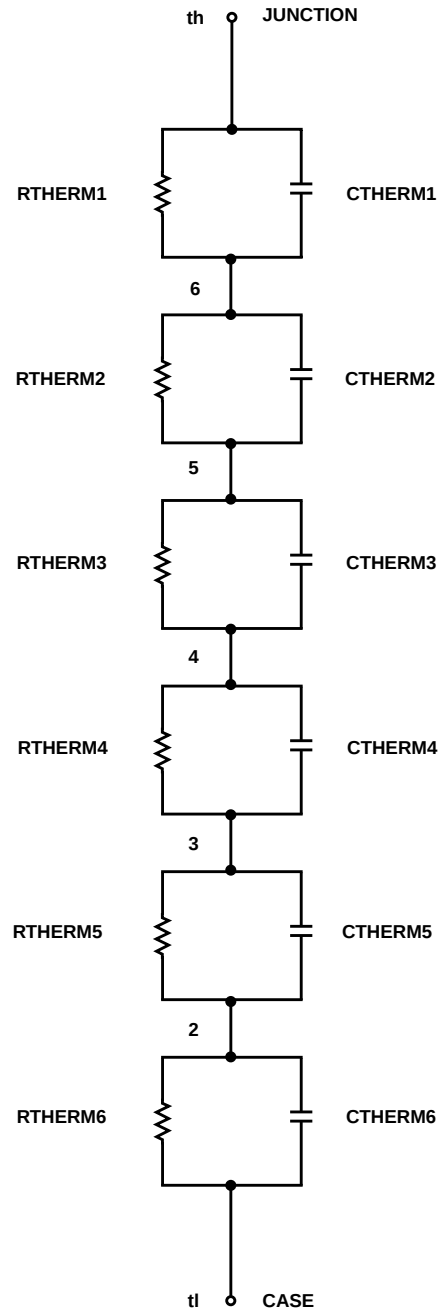
RTHERM1 TH 6 8.50e-3
 RTHERM2 6 5 2.10e-2
 RTHERM3 5 4 9.85e-2
 RTHERM4 4 3 2.25e-1
 RTHERM5 3 2 2.66e-1
 RTHERM6 2 tl 2.98e-1

SABER Thermal Model

SABER thermal model HUF76432

```
template thermal_model th tl
thermal_c th, tl
{
    ctherm.ctherm1 th 6 = 2.40e-3
    ctherm.ctherm2 6 5 = 8.40e-3
    ctherm.ctherm3 5 4 = 9.30e-3
    ctherm.ctherm4 4 3 = 9.60e-3
    ctherm.ctherm5 3 2 = 1.28e-3
    ctherm.ctherm6 2 tl = 1.07e-1

    rtherm.rtherm1 th 6 = 8.50e-3
    rtherm.rtherm2 6 5 = 2.10e-2
    rtherm.rtherm3 5 4 = 9.85e-2
    rtherm.rtherm4 4 3 = 2.25e-1
    rtherm.rtherm5 3 2 = 2.66e-1
    rtherm.rtherm6 2 tl = 2.98e-1
}
```



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Sales Office Headquarters

NORTH AMERICA

Intersil Corporation
 P. O. Box 883, Mail Stop 53-204
 Melbourne, FL 32902
 TEL: (407) 724-7000
 FAX: (407) 724-7240

EUROPE

Intersil SA
 Mercure Center
 100, Rue de la Fusee
 1130 Brussels, Belgium
 TEL: (32) 2.724.2111
 FAX: (32) 2.724.22.05

ASIA

Intersil (Taiwan) Ltd.
 7F-6, No. 101 Fu Hsing North Road
 Taipei, Taiwan
 Republic of China
 TEL: (886) 2 2716 9310
 FAX: (886) 2 2715 3029